

<b>Notice of References Cited</b>	Application/Control No. 10/543,141		Applicant(s)/Patent Under Reexamination AIZAWA ET AL.	
	Examiner MARIANNE L. PADGETT		Art Unit 1792	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0169049 A1	07-2008	Yakabe et al.	148/222
*	B	US-6,780,375 B2	08-2004	Hirano et al.	420/530
*	C	US-4,077,810	03-1978	Ohuchi et al.	148/552
*	D	US-4,909,862	03-1990	Tachikawa et al.	148/222
*	E	US-4,597,808	07-1986	Tachikawa et al.	148/222
*	F	US-4,522,660	06-1985	Suzuki et al.	148/222
*	G	US-6,376,375 B1	04-2002	Hewitt-Bell et al.	438/687
*	H	US-6,180,189 B1	01-2001	Steinwandel et al.	427/535
*	I	US-5,248,384 A	09-1993	Lin et al.	216/77
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63-50456 A	03-1988	Japan	Yamaguchi et al.	427/535
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.